Search	Notes
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/721,178	LU ET AL.	
Examiner	Art Unit	
Daniel Kim	2185	

	SEARCHED		
Class	Subclass	Date	Examiner
370	503	9/26/2006	DK
711	169	9/26/2006	DK
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
EAST Database Search	9/26/2006	DK
IEEE Xplore Search	9/26/2006	DK
Interference Search	9/26/2006	DK
Consulted with Primary Examiner Pierre Vitale	9/26/2006	· DK
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